

Novel Silicon Carbide Integrated Power Module for EV application

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Abstract— The successful penetration of Electric Vehicles (EVs) into the global automotive markets requires the developments of cost effective, high performance and high integration power electronic systems. The present work is concerned with the structural integration of power electronic converters to meet targets for increased power density, improved electrical performance and reduced cost without compromising thermal performance or reliability for EV applications. In particular, a SiC power module to integrate multiple functional elements, i.e. semiconductor devices, DC-link capacitors, output filters, current sensing, and gate driver within a single enclosure sharing a common cooling circuit has been designed and fabricated. Electrical test results showed very smooth waveforms of the outputs, verifying the high frequency switching capacity of the fabricated power module.

Keywords— *Integrated Power Module; Power Electronics; half-bridge; SiC devices, output filter, Power Electronic Packaging, direct cooling*

I. INTRODUCTION

It is envisaged that over the coming decades, Electric Vehicles (EVs) is one or more variant forms which will achieve substantial penetration into the global automotive markets, particularly for cars and vans. The most significant barrier impeding the commercialization of EVs is currently the cost. In addition, high power density and low system weight are additional requirements for power systems implemented into mobile equipment.

A typical power converter consists of semiconductor power modules, a physically separate DC-link, a separate input and/or output filter, EMI filters, gate drivers, controllers and sensors. Traditionally, each of these entities is designed separately, cooled separately and has its own operational requirements. Such an approach is restrictive: it overlooks the strong interactions between the elements, for example in realizing a converter-wide thermal and electromagnetic design, and cannot take advantage of potential performance gains and space saving from physical integration at “die” level. Furthermore, the interconnection of physically large discrete components makes it difficult to reduce parasitic inductances to an acceptably low level and leads to concentrated thermal sources that are difficult to cool effectively.

SiC power devices can be switched at much high frequency than Si counterparts. If they are integrated into power module using the conventional packaging structure, it would lead to dramatically high overshoots during the turn-off/turn-on stages due to parasitic inductance induced by such structure. Therefore, to achieve their full performance with regard to low switching losses and low conduction losses, they can only be used if the module layout is designed with low parasitic inductances and low thermal impedance [1].

Through addressing the challenges described above, a new solution has been presented by the authors [2] for the structural integration of power electronic converters to meet targets for increased power density, improved electrical performance and reduced cost without compromising thermal performance or reliability. The aim is to integrate multiple functional elements, i.e. semiconductor devices, DC-link capacitors, output filters, current sensing, and gate driver within a single enclosure sharing a common cooling circuit. The highly integrated matrix converter package has been reported based on three Single Basic Power Cell (SBPC) unit with an input filtering component enclosed in an integrated direct-substrate jet impingement cooling system that cools the whole system, the power switches and the integrated inductors [2]. The work presented in this paper focuses more on the design, fabrication and characterization of the Single Basic Power Cell (SBPC) unit.

II. SINGLE BASIC POWER CELL DESIGN

The design presented in this paper consists of a basic topology circuit. This circuit consists of two level leg or so-called “half H-bridge” configurations using wide bandgap switching devices on each switch position. It will be referred to as Standard Basic Power Cell (SBPC) throughout this paper. This SBPC is formed using two switches and two diodes. It also includes multiple functional elements with an integrated inductor, on the output side that allows first high current density capability [3], and provide internal filtering configurations at source to achieve a clean, overshoot free commutation. Fig. 1 show the electrical circuit and a cross-sectional schematic of the proposed SBPC unit.

The designed SBPC unit consists of the following components:

- Single Direct Bonded Copper (DBC) substrate custom-designed to accommodate the passive and active

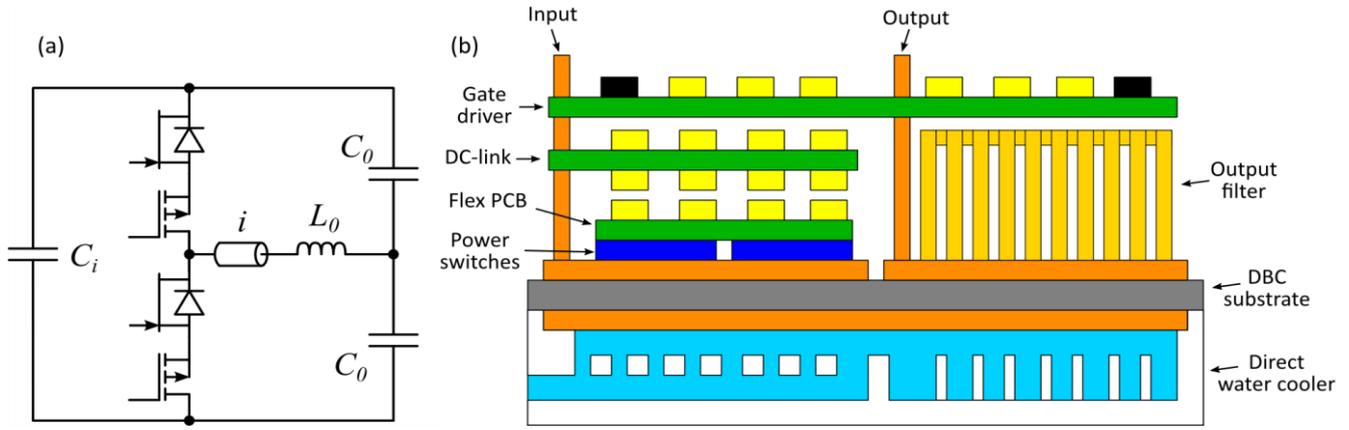


Fig. 1. (a) Single Basic Power Cell (SBPC) circuit and (b) a cross-sectional schematic of the SBPC design placed on direct water cooling system

components. It consists of 0.2mm-thick copper (Cu) on each side of the ceramic and 1mm-thick aluminum nitride (AlN) because of its high thermal conductivity compared to other ceramics [4]

- Each switch position of the half H-bridge include four 1.2kV SiC JFETs which are normally-on devices [5] and four SiC P-MOSFETs (recommended as a direct drive of the JFETs [6]). It should be noted that SiC MOSFETs and GaN device can be also used in this packaging concept.
- Flex PCB to connect all the power switches together, to replace the Al wirebonds as in a conventional power package
- Each SiC JFET switch pair in the designed half H-bridge has its own set of decoupling capacitors placed directly above it on the flex PCB, very close to the commutation loop, to reduce any parasitic inductance
- DC-link capacitors that are populated on a separate PCB and is very close to the commutation loop
- Integrated current sensing at mid-point level
- NTC thermistor to measure the temperature on the DBC substrate
- Integrated inductors on the output side that allows first high current density capability [3], and provide internal filtering configurations to achieve a clean, overshoot free commutation. These inductors are machined from a Cu bulk to create the desired winding shape, and bonded on the DBC substrate where they are cooled using a shared cooling system
- Custom-designed gate driver placed on top of the assembly
- Pin terminals for the interconnection to provide a lower parasitic inductance than the busbars
- Integrated cooler that allows direct cooling on the backside of the DBC substrate, with two configurations: jet impingement cells [7] to cool down each power switch, and turbulent structure cells to cool down the

integrated inductors. The parts of this special enclosure and coolant manifold were made of plastic and manufactured by employing additive manufacture (three dimensional, 3-D printing) technology. The manifold was designed to provide the liquid passageways for coolant passing through mainly by the jet impingement areas, and then the turbulent structure cells.

The advantages of such a package is to significantly reduce electromagnetic emissions compared to the individual elements, volume and weight saving through a shared enclosure and cooling. The three phase converter with the three SBPC and the input filtering components and the shared integrated cooling system are shown in [2]. This paper focuses more on the fabrication of the SBPC unit.

III. FABRICATION OF THE SBPC UNIT

A. Assembly process

Silver (Ag) sintering was chosen for the topside die interconnects because it has higher thermal conductivity and improved reliability than solder [8]. Furthermore, since the melting temperature after sintering (960 °C) is higher than the sintering temperature (≤ 260 °C), multiple assembling processes can be done without affecting the previously-sintered joints. The inductors, the NTC thermistor, the current sensor, the P-MOSFETs and the pin terminals are bonded onto the DBC substrate using soldering alloy.

The Al top metal of the as-received 1.2kV SiC JFETs was first coated with Ti and Au, using e-beam evaporation through a shadow mask, to provide a suitable surface for sintering. The die attach to the DBC substrate was accomplished with higher melting point solder alloy. The assembling process for constructing the designed SBPC unit module is described as follows:

- 1) Stencil print pressure-assisted nano-silver paste on the flex PCB
- 2) Dry the paste in the oven @130°C for 30min
- 3) Sinter the topside of the SiC JFETs, on the flex PCB using a die bonder for accurate positioning and for sintering.

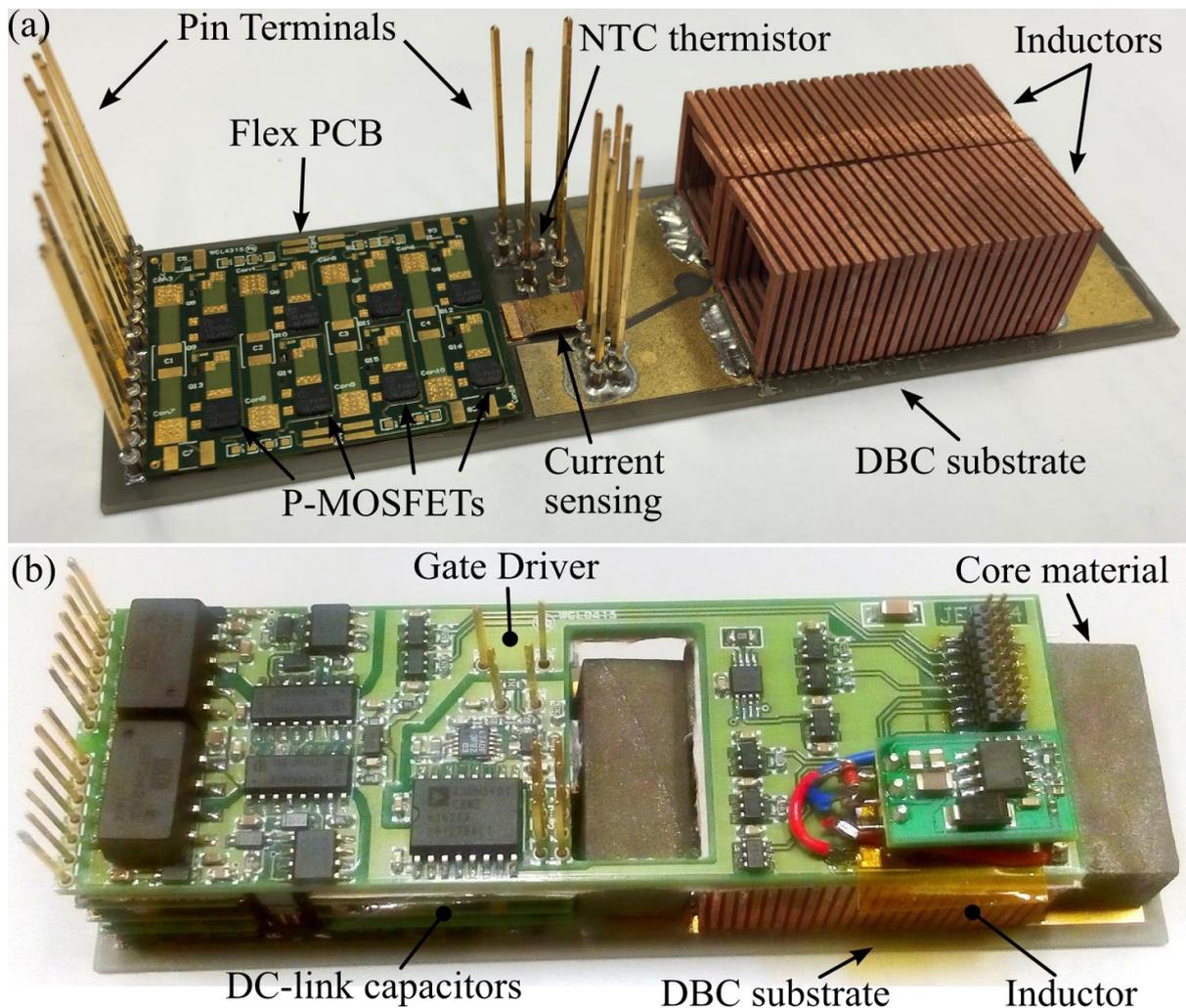


Fig. 2. (a) Photo showing the Flex PCB, the P-MOSFETs, the Pin terminal, the NTC thermistor, the current sensing and the inductors assembled on the DBC substrate and (b) the fully assembled SBPC unit

The sintering process was performed at 250°C, 10MPa for 2min.

4) Bond the bottom side of the SiC JFETs which are already sintered on the flex, to a DBC substrate using solder alloy (SnAgCu) with higher melting point

5) Bond SiC P-MOSFETs, the inductors, the NTC thermistors, the current sensor, the input/output pin terminals on the DBC substrate using solder alloy (Sn37Pb) with lower melting point. Fig. 2a shows the SBPC package at this stage.

6) At the same time, all the DC-link capacitors are soldered on a separate PCB. The decoupling capacitors are manually soldered on its corresponding position on the Flex PCB

7) Insert the core material between the windings of the inductors

8) Mount the DC-link capacitors and the gate driver on the topside as shown in Fig.2b.

B. X-ray imaging

The bonding position of each SiC JFET was examined non-destructively using X-ray system. This was carried out on a Zeiss Xradia Versa-XRM500 CT system. X-ray projection images

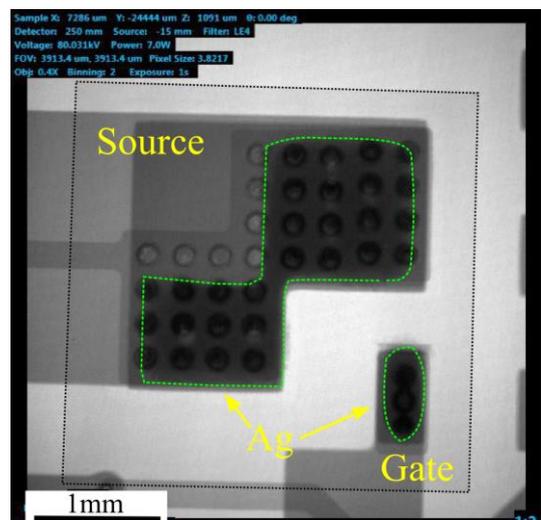


Fig. 3. X-ray projection image showing one SiC JFET (dashed line in black) sintered on the flex PCB. The silver areas at the gate and the source pad are shown in yellow.

were performed for all the devices once sintered on the flex PCB. Fig. 3 shows the projection image of one sintered SiC JFET showing the Ag areas at the gate and the source pad with spatial resolution of $\sim 3.8 \mu\text{m}$. This shows an accurate positioning with no large voids in the bond line of the topside attachment. The Ag paste are confined in its specific area and there is no short-circuit between the gate and source pad. It should be noted that the circular dots that appears in Fig. 3 represents the vias within the flex PCB.

IV. ELECTRICAL EVALUATION

After the assembling process, the constructed SBPC module was tested to illustrate the electrical performance. Fig. 4 shows the electrical circuit and the corresponding measured waveforms of the SBPC at a switching frequency of 143 kHz. The experimental parameters used for the electrical test are listed in **Error! Reference source not found..** The SBPC unit was tested in a DC-DC mode where the nominal DC-link input voltage of 190V (illustrated in blue in Fig4b) with an output voltage of $\sim 48\text{V}$ (illustrated in green in Fig4b).

The voltage waveform at the mid-point of the half-bridge modules and the measured output current are illustrated in Fig4c in black and red, respectively. It should be noted that test is performed with an open loop fixed 29% duty cycle, hence the poor regulation on the output voltage (V_{out}). Note probe induced

TABLE I. EXPERIMENTAL PARAMETERS

Continuous switching test	
Part	Type
Drain current (I_D)	30A
Bus voltage (V_{bus})	190V
Gate voltage (V_{gate})	+3V/-18V
Duty cycle	0.29
Switching frequency	143kHz
Junction temperature (T_j)	22°C (Ambient temperature)

noise is present on the output current (I_{out}) waveforms are shown in Fig4c and has been filtered for display purposes.

One can see the clean switching edges across V_{DS} , with no discernible overshoot and minimal ringing, highlighting the effective integration of the input capacitors and creation of the low inductance commutation loop. The power level tested (about 1.5kW) is lower than the rated power because the objective of this work is to verify the high switching capability of the SBPC unit.

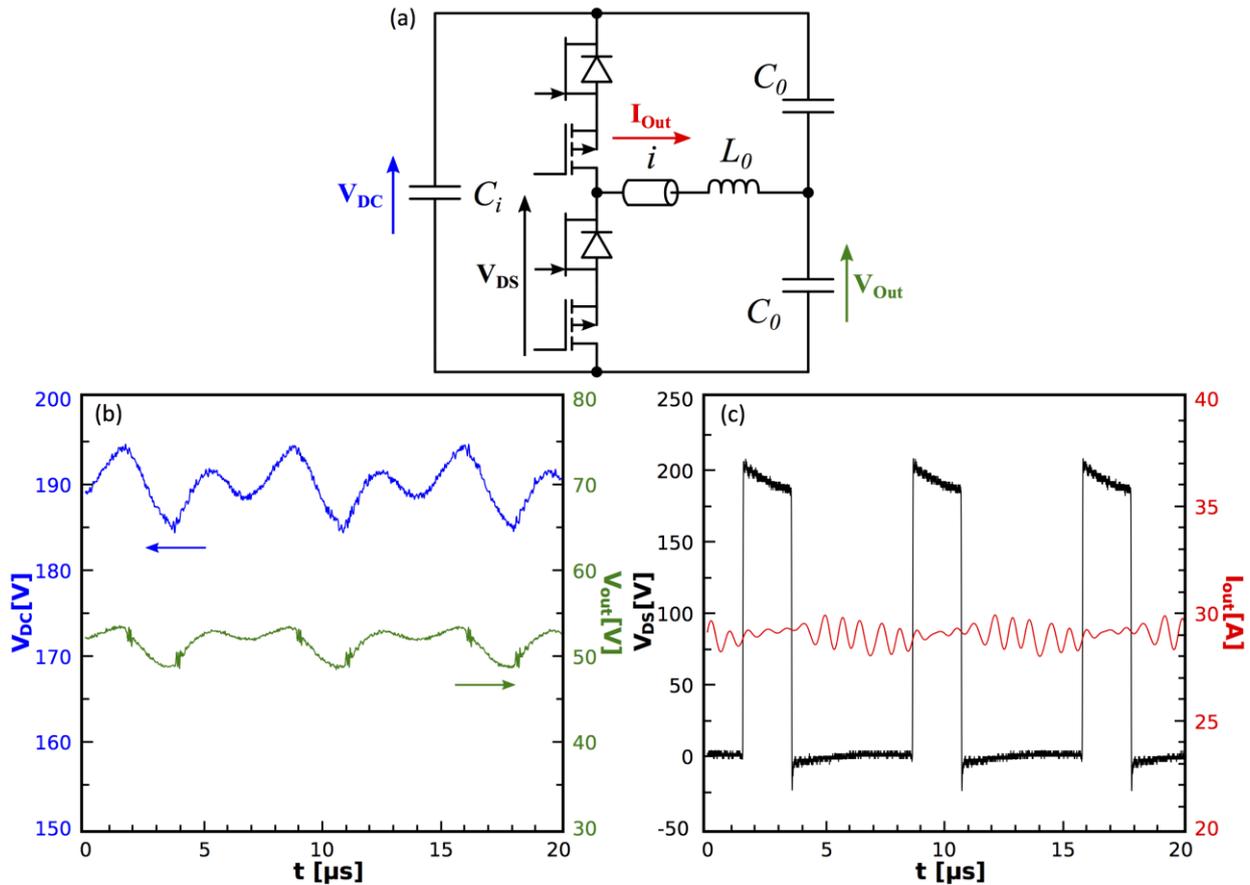


Fig. 4. (a) Electrical circuit and (b) &(c) the corresponding measured waveforms of the designed module at a switching frequency of 143kHz

It should be noted that the SBPC includes filters aiming to filter the high frequency harmonics (values are $L_o = 25 \mu\text{H}$ and $C_o = 1.8 \mu\text{F}$). The advantages of including filters inside the power module are numerous: the power converter system can be made to be more compact, preventing propagation of harmonics and EMI, while from an electrical machine perspective, the levels of damaging high speed common mode voltage (CMV) are drastically reduced, increasing the electrical machine's lifetime.

V. CONCLUSION

This paper presents the design, assembling process, and electrical switching test of a highly integrated fully SiC power module for Electric Vehicles (EV) application. The concept is based on a fully integration of all the components including the power switches, DC-link capacitors, output filter, gate driver and current sensing in one Single Basic Power Cell (SBPC) unit.

The assembling process of the SBPC has then been presented in detail using silver sintering interconnects and the flex PCB assembled onto a DBC substrate. Embedded output filter components are also assembled on the same DBC substrate enabling to be cooled using a shared cooling system with the power switches. An electrical switching test at a switching frequency of 143kHz was carried out to evaluate the electrical performance of the designed and assembled IPM. This shows a clean switch with no discernible overshoot and minimal ringing, highlighting the effective low inductance design. Further work, the electrical test will be performed at the rated power level of the integrated power module for high power density application.

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